Search Notes				

7	Application/Control No.	Applicant(s)/Patent under Reexamination	
1	10/075,283	IWAYAMA ET AL.	
E	Examiner	Art Unit	
1	Neveen Abel-Jalil	2165	

Neveen Abel-Jalil

	SEAR	CHED	
Class	Subclass	Date	Examiner
707	1-10	7/25/2005	NAJ
715	500	7/25/2005	NAJ
715	513	7/25/2005	NAJ
Search	Updated	7/25/2005	NAJ
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	DATE	EXMR
Search Updated	7/25/2005	NAJ